

IGBT Modules

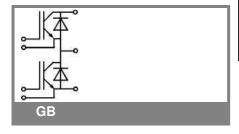
SKM 100GB173D

Features

- N channel, Homogeneous Si
- Very low tail current with low temperature dependence
- High short circuit capability, self limiting to 6 x I_{cnom}
- · Latch-up free
- Fast & soft inverse CAL diodes
- Isolated copper baseplate using DCB Direct Copper Bonding
- Large clearance (10 mm) and creepage distances (20 mm).

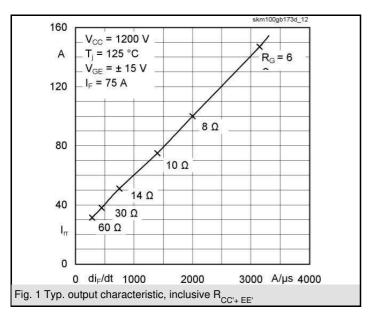
Typical Applications

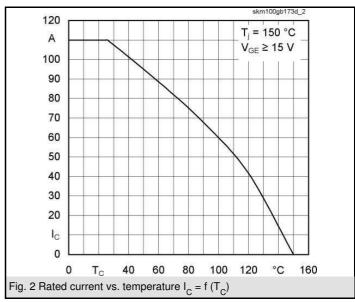
- AC inverter drives on mains 575 - 750 $\rm V_{AC}$
- DC bus voltage 750 -1200 V_{DC}
- Public transport (auxiliary syst.)
- Switching (not for linear use)

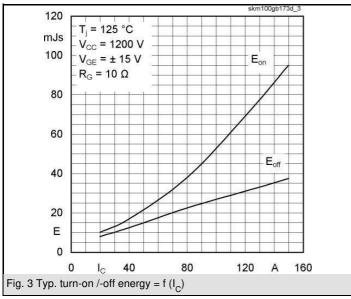


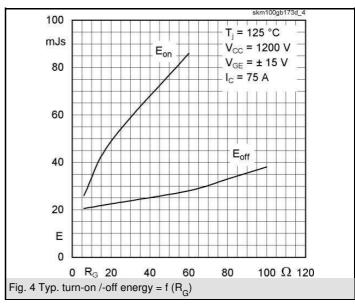
Absolute	Maximum Ratings	T _c = 25 °C, unless otherwise	T _c = 25 °C, unless otherwise specified					
Symbol	Conditions	Values	Units					
IGBT								
V_{CES}		1700	V					
V _{CES}	T _c = 25 (80) °C	110 (75)	Α					
I _{CRM}	$T_c = 25 (80) ^{\circ}C$ $t_p = 1 \text{ ms}$	150	Α					
V_{GES}		± 20	V					
T_{vj} , (T_{stg})	$T_{OPERATION} \leq T_{stg}$	- 40 + 150 (125)	°C					
V_{isol}	AC, 1 min.	4000	V					
Inverse diode								
I _F	T _c = 25 (80) °C	80 (50)	Α					
I _{FRM}	$t_p = 1 \text{ ms}$	150	Α					
I _{FSM}	$t_p = 10 \text{ ms; sin.; } T_j = 150 ^{\circ}\text{C}$	720	Α					

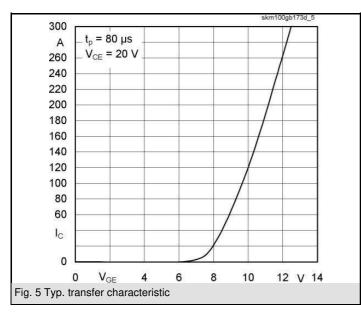
Characteristics		_c = 25 °C, unless otherwise specified					
Symbol	Conditions	min.	typ.	max.	Units		
IGBT							
$V_{GE(th)}$ I_{CES} $V_{CE(TO)}$ r_{CE}	$\begin{aligned} & V_{GE} = V_{CE}, \ I_{C} = 6 \ mA \\ & V_{GE} = 0, \ V_{CE} = V_{CES}, \ T_{j} = 25 \ (125) \ ^{\circ}C \\ & T_{j} = 25 \ (125) \ ^{\circ}C \\ & V_{GE} = 15 \ V, \ T_{j} = 25 \ (125) \ ^{\circ}C \end{aligned}$	4,8	5,5 0,1 1,65 (1,9) 23,3 (33,3)		V mA V mΩ		
V _{CE(sat)}	I _{Cnom} = 75 A, V _{GE} = 15 V, chip level		3,4 (4,4)	3,9 (5)	V		
C _{ies} C _{oes} C _{res} L _{CE} R _{CC'+EE'}	under following conditions $V_{GE} = 0$, $V_{CE} = 25$ V, $f = 1$ MHz res., terminal-chip $T_c = 0.75$ (1) °C		11 1 0,28	30	nF nF nF nH mΩ		
$t_{d(on)}$ t_r $t_{d(off)}$ t_f t_{on} (E_{off})	$V_{CC} = 1200 \text{ V}, I_{Cnom} = 75 \text{ A}$ $R_{Gon} = R_{Goff} = 10 \Omega, T_j = 125 \text{ °C}$ $V_{GE} = \pm 15 \text{ V}$		40 45 400 56 35 (21)		ns ns ns ns mJ		
Inverse d	iode	1			1		
$\begin{aligned} &V_{F} = V_{EC} \\ &V_{(TO)} \\ &r_{T} \\ &I_{RRM} \\ &Q_{rr} \\ &E_{rr} \end{aligned}$	$\begin{split} & I_{Fnom} = 75 \text{ A; V}_{GE} = 0 \text{ V; T}_j = 25 \text{ (125) °C} \\ & T_j = 125 \text{ () °C} \\ & T_j = 125 \text{ () °C} \\ & I_{Fnom} = 75 \text{ A; T}_j = 25 \text{ (125) °C} \\ & di/dt = A/\mu s \\ & V_{GE} = V \end{split}$		2,2 (2) 1,3 9 38 (51) 8 (19)	2,7 (2,3) 1,5 13	V V mΩ A μC mJ		
$ \begin{aligned} \textbf{FWD} \\ \textbf{V}_{F} &= \textbf{V}_{EC} \\ \textbf{V}_{(TO)} \\ \textbf{r}_{T} \\ \textbf{I}_{RRM} \\ \textbf{Q}_{rr} \\ \textbf{E}_{rr} \end{aligned} $	I_F = 100 A; V_{GE} = V, T_j = 25 (125) °C T_j = 125 () °C T_j = 125 () °C I_F = 100 A; T_j = 25 (125) °C di/dt = A/ μ s V_{GE} = V		2,2 (1,9) 1,2 7 10 (27)	2,7 (2,4) 1,5 9	V V mΩ A μC mJ		
$ \begin{array}{l} \textbf{Thermal} \ \textbf{C} \\ \textbf{R}_{th(j\text{-c})} \\ \textbf{R}_{th(j\text{-c})D} \\ \textbf{R}_{th(j\text{-c})\text{FD}} \\ \textbf{R}_{th(c\text{-s})} \end{array} $	per IGBT per Inverse Diode per FWD per module			0,2 0,63 0,4 0,05	K/W K/W K/W		
Mechanic M _s M _t	to heatsink M6 to terminals M5	3 2,5		5 5	Nm Nm		
w				160	g		

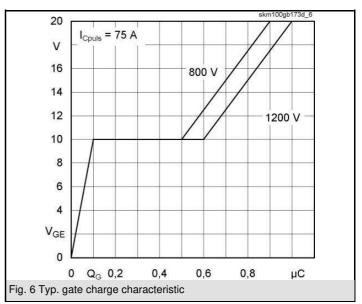


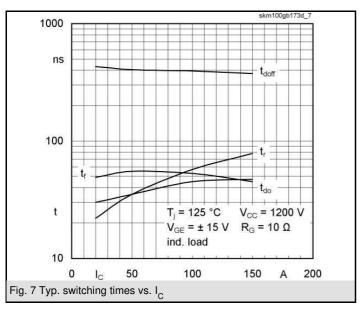


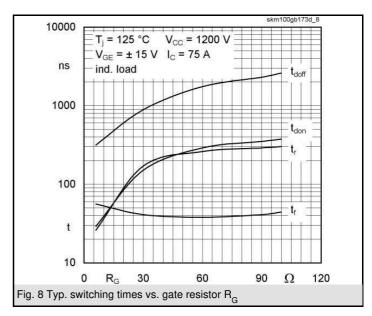


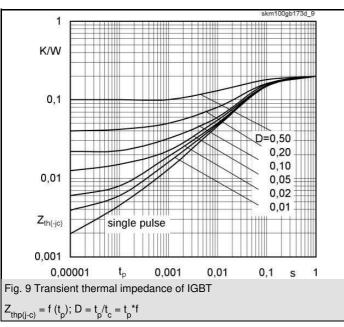


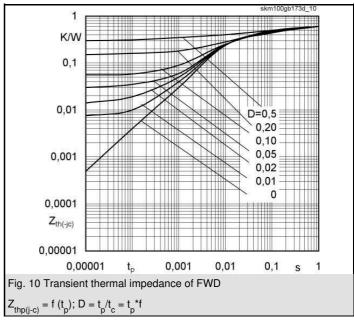


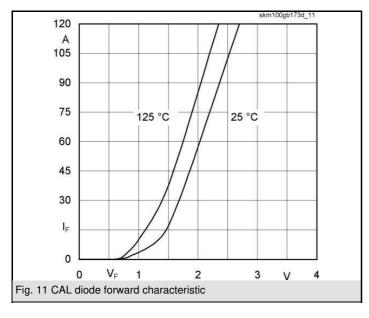


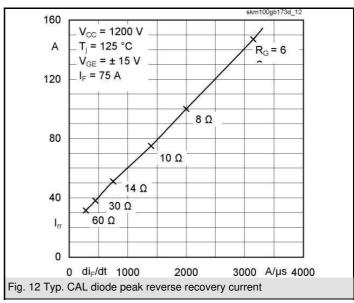


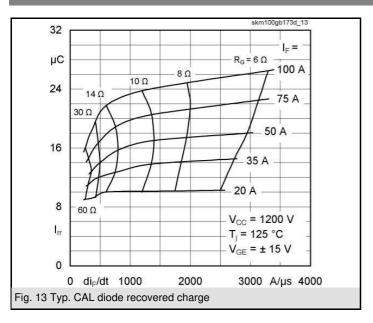


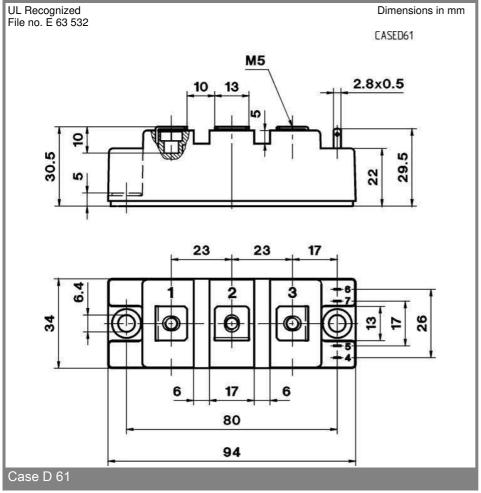


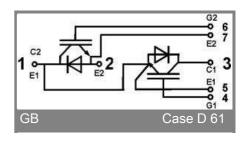


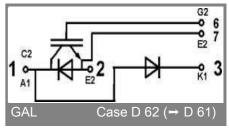












This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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